

# Fabio Soci

## List of Publications by Year in descending order

Source: <https://exaly.com/author-pdf/10767752/publications.pdf>

Version: 2024-02-01

1  
papers

28  
citations

3311381

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3475538

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1  
times ranked

70  
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#	ARTICLE	IF	CITATIONS
1	Hot-Electron Degradation of AlGaIn/GaN High-Electron Mobility Transistors During RF Operation: Correlation With GaN Buffer Design. IEEE Electron Device Letters, 2015, 36, 1011-1014.	3.9	28